

Search Notes

Application/Control No.

10/643,370

Examiner

Brian L. Albertalli

Applicant(s)/Patent under
Reexamination

DROPPO ET AL.

Art Unit

2626

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	4/26/2007	BA
IEEE Search - Search Terms: SNR, signal to noise ratio, taylor, random variable, probabalistic	4/26/2007	BA
INSPEC Search - Search Terms: SNR, signal to noise ratio, taylor, random variable, probabalistic	4/26/2007	BA
ACM Search - Search Terms: SNR, signal to noise ratio, taylor, random variable, probabalistic	4/26/2007	BA